

IDENTIFICATION

PRODUCT CODE: MAINDEC-06-DIWAC-E-D  
PRODUCT NAME: POP-08 MAINDEC INDEX  
PRODUCT DATE: AUGUST, 1977  
MAINTAINER: RELEASE ENGINEERING

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FOREWARD

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THE INTENT OF THIS MAINDEX IS TO SHOW THE LATEST DIAGNOSTIC PROGRAMS, AND THEIR LATEST MCO REVISION LEVEL. THE INDEX WILL BE PUBLISHED MONTHLY. THE COLUMN HEADINGS HAVE THE FOLLOWING MEANINGS.

UPDATED	AN * INDICATES THAT THIS MAINDEX HAS BEEN CHANGED SINCE THE LAST ISSUE OF THIS DOCUMENT.
DESIGNATION	MAINDEX CODE OF THE LATEST DIAGNOSTIC.
REV	REVISION LEVEL OF THE PROGRAM.
MCO	INDICATES THE LATEST MCO REVISION LEVEL OF THE PROGRAM.
PRODUCT NAME	TITLE OF THE DIAGNOSTIC REFERRED TO BY THE DESIGNATION CODE.
EFFECTIVE DATE	PROGRAM DATE
OPTIONS TESTED	THIS FIELD LISTS ALL OPTIONS TESTED BY THE DIAGNOSTIC PROGRAM.
CPU PROGRAM RUNS IN	INDICATES PROCESSOR PROGRAM IS DESIGNED TO RUN IN.
CORE K TO LOAD AND RUN	THE MEMORY SIZE REQUIRED TO LOAD AND EXECUTE THE PROGRAM.
MODES OF OPERATION	EX = EXEC MODE US = USER MODE KE = KERNEL MODE SY = SYSTEM EXERCISER DM = DIAGNOSTIC MONITOR SP = SPECIAL USER ST = STAND ALONE

DISTRIBUTION/SUPPORT

CODE ALL DIAGNOSTICS LISTED IN THIS MAINDEX INDEX HAVE A DISTRIBUTION CODE OF G: (I.E.) ALL PROGRAMS ARE AVAILABLE THROUGH THE SDC.

SUPPORT CATEGORY CODES ARE AS FOLLOWS:

A = DIGITAL PROVIDES ON-SITE INSTALLATION SUPPORT SPECIFIED IN THE APPLICABLE SOFTWARE PRODUCT DESCRIPTION.

2 ■ DIGITAL PROVIDES PROBLEM REPORTING  
SERVICE.

ANY COMMENTS OR QUESTIONS ABOUT THIS INDEX PLEASE CONTACT  
RELEASE ENGINEERING, MAYNARD EXTENSION 4055.  
THANK YOU.

IDENTIFICATION

PRODUCT CODE:

PRODUCT NAME:

POP- 8E MAINDEC INDEX BY APPLICATION



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 \*\*\* APPLICATION: PROCESSOR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K TO LOAD RUN	SYSTEM BASED	MODES OF OPEN	TEXT CODE
M- 0E-D0A	B	INSTRUCTION TEST PART 1	5-10-71		0E	4K	4K	ST	G/B
M- 0E-D0B	B	INSTRUCTION TEST PART 2	8-15-74		0E	4K	4K	ST	G/B
M- 0E-D0C	C	RANDOM OCA TEST	6-11-71		0E	4K	4K	ST	G/B
M- 0E-D0H	C	RANDOM JMP TEST	6-11-71		0E	4K	4K	ST	G/B
M- 0E-D0I	B	BASIC JMP-JMS TEST	6-11-71		0E	4K	4K	ST	G/B
M- 0E-D0J	C	RANDOM JMP-JMS TEST	8-15-74		0E	4K	4K	ST	G/B
M- 0E-D0A	A	INSTRUCTION TEST PART 1	10-08-71	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0B	A	INSTRUCTION TEST PART 2	10-08-71	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0C	A	ADDER TEST	10-08-71	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0D	A	RANDOM AND TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0E	A	RANDOM TAU TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0F	A	RANDOM ISZ TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0G	A	RANDOM OCA TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0H	A	RANDOM JMP TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0I	A	BASIC JMP-JMS TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0J	A	RANDOM JMP-JMS TEST	8-15-74	PMK=01	0E	4K	4K	ST	G/B
M- 0E-D0K	A	ADDER TEST	8-15-74		0E	4K	4K	ST	G/B
M- 0E-D0F	C	RANDOM ISZ TEST	6-11-71		0E	4K	4K	ST	G/B

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 \*\*\* APPLICATION: PROCESSOR OPTION \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K TO LOAD RUN	SYSTEM BASED	MODES OF OPEN	TEXT CODE
M- 0E-D0P	C	D08-E INTERPROCESSOR BUFFER	10-27-71	D08-E	0E	4K	4K	ST	G/B
M- 0E-D0A	B	PLOTTER CONTROL AND DISPLAY (XY8E)	5-16-71	XY8-E	0E	4K	4K	ST	G/B
M- 0E-D0A	C	D0K-E CLOCKS DIAGNOSTIC	10-08-71	UK8-E	0E	4K	4K	ST	G/B
M- 0E-D0M	A	PMK=01 KPB-E POWER FAIL TEST	8-15-74	KPB-E /PMK=01	0E	4K	4K	ST	G/B

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 \*\*\* APPLICATION: MEMORY \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFEKTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPEN	TEXT CODE
M- 0E-01A	B	MMS-E 4K MEMORY CHECKERBOARD	6-07-71		0E	4K 4K		ST	G/B
M- 0E-01E	C	PDP-0E MEMORY ADDRESS	6-11-71		0E	4K 4K		ST	G/B
M- 0E-01G	B	PDP-0E MEMORY POWER ON/OFF TEST	6-11-71		0E	4K 4K		ST	G/B
M- 0E-01I	B	MIS-E BOOTSTRAP DIAG	1-17-72	MIS-E	0E 0H 0F	4K 4K		ST	G/B
M- 0E-09K	A	MEMORY ADDRESS TEST	10-08-71	MMS-E /PMK-01 / MMS-EH /MMS-EJ	0E	4K 4K		ST	G/B
M- 0E-09L	A	MMS-E 4K MEM CHECKERBD	8-15-74	MMS-E /MMS-EH / MMS-EJ /PMK-01	0E	4K 4K		ST	G/B
M- 0E-09N	A	MEMORY POWER ON/OFF TEST	8-15-74	MMS-E /MMS-EH / MMS-EJ /PMK-01	0E	4K 4K		ST	G/B
M- 0E-09P	A	JMP SELF TEST	8-15-74	MMS-E /MMS-EH / MMS-EJ /PMK-01	0E	4K 4K		ST	G/B
M- 0E-0HMP4	A	PDP-0E EXTENDED MEMORY PARITY TEST	2-24-72	KMS-E	0E	0K 0K		ST	G/B
M- 0E-0IF	B	PDP-0E EXTENDED MEMORY ADDRESS TEST	6-14-71	KMS-E	0E	0K 0K		ST	G/B
M- 0E-0GN	B	PDP-0E JMP SELF	1-19-71		0E	4K 4K		ST	G/B

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 \*\*\* APPLICATION: CARD \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFEKTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPEN	TEXT CODE
M- 0E-020	B	40 COL OPTICAL MARK CARD READER TES	8-30-71	CM0-E	0E	4K 4K		DT	G/d



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 \*\* APPLICATION: UTILITY \*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPER	IXXDP TEXT	IO/S ICDDE
M= BE-X61NA	A	SELF-START BINARY LOADER	8-15-7#		ALL BE	4K 4K		ST		G/B
D= BE-EUZ	C	TOBE VECTAPE FORMATTEN	8-15-7#		BE	4K 4K		ST		G/B



IDENTIFICATION

PRODUCT CODE:

PRODUCT NAME:

PDP- 8I MAINDEC INDEX BY APPLICATION



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 \*\*\* APPLICATION: PROCESSOR \*\*\*  
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DESIGNATION	REV/MCD	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPEN	IXXDPID/S TEXT CODE
M- 81-001	C	INSTRUCTION TEST PART 1	8-15-74		81	4K	4K	ST	G/B
M- 81-002	B	INSTRUCTION TEST PART 2	8-15-74		81	4K	4K	ST	G/B

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 \*\*\* APPLICATION: PROCESSOR OPTION \*\*\*  
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DESIGNATION	REV/MCD	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPEN	IXXDPID/S TEXT CODE
M- 81-008	A	PDP-8I EAE TEST	5-15-68	KEO-I	81	4K	4K	ST	G/B
M- 81-00A	A	PDP-8I INSTRUCTION TEST 3A	5-15-68		81	4K	4K	ST	G/B

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 \*\*\* APPLICATION: MEMORY \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	IEFFECTIVE:   DATE	OPTION(S)   TESTED	IPROC PROGRAM:   RUNS IN	CORE K TO SYSTEM   LOAD RUN   BASED	MODES   OF OPER	IXXDP:U/S   EXT   CODE
M= 8I-D4C	A	POP-8I MEMORY PARITY IOT TEST	8-15-74	MPB-I	8I	4K 4K	ST	6/8

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 \*\*\* APPLICATION: CLOCKS \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	IEFFECTIVE:   DATE	OPTION(S)   TESTED	IPROC PROGRAM:   RUNS IN	CORE K TO SYSTEM   LOAD RUN   BASED	MODES   OF OPER	IXXDP:U/S   EXT   CODE
M= 8I-D8A	D	REAL TIME CLOCK (KWB1)	10-21-68	KWB-I		4K 4K	ST	6/8

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 \*\*\* APPLICATION: CARD \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPEN	TEXT TEXT	CODE CODE
M- 61-02H	A	40 CUL OPTICAL MARK CARD READER	9-22-70	CM6-1	BI	4K 4K	ST			G/B

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 \*\*\* APPLICATION: TERMINALS \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TO SYSTEM BASED	MODES OF OPEN	TEXT TEXT	CODE CODE
M- 61-06C	E	KV61 DISPLAY DIAGN	8-05-68	KV8-1	BI	4K 4K	ST			G/B

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 \*\*\* APPLICATION: COMM. EQUIPMENT \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM MUN5 IN	CORE K LOAD RUN	SYSTEM BASED	MODES OF OPER	EXXDPLOS TEXT CODE
M- 8I-02C	A	680/I TTY RELIABILITY TEST	5-19-70	UL8-I /680-I	BI	4K	4K	ST	G/B
M- 8I-08B	B	UC08 ON LINE TEST (T2)	4-22-70	UC08	BI	4K	4K	ST	G/B
M- 8I-08C	A	689-AG CONTROL AND DATA TEST	11-19-68	689-AG	BI	4K	4K	ST	G/B
M- 8I-08D	A	689-AG ON-LINE DIAG EXERC	11-05-68	689-AG	BI	4K	4K	ST	G/B
M- 8I-08E	A	UC08F&DC08H OFF LINE TEST	3-09-70	UC08-F /DC08H	BI	4K	4K	ST	G/B
M- 8I-08F	A	DC08F & DC08H ON LINE TEST	3-09-70	UC08-F /DC08-H	BI	4K	4K	ST	G/B



IDENTIFICATION

PRODUCT CODE:

PRODUCT NAME:

PDP-8L MAINDEC INDEX BY APPLICATION



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 \*\*\* APPLICATION: PROCESSOR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TU(SYSTEM) BASED	MODES OF OPER	TEXT CODE
M- 0L-004	B	MEMORY PROTECT TEST	5-06-71		0L	4K 4K		ST	G/B

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 \*\*\* APPLICATION: MEMORY \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD RUN	TU(SYSTEM) BASED	MODES OF OPER	TEXT CODE
M* 0L-01G	C	PDP-0L EXTENDED MEMORY CONTROL (8K)	8-15-74	KM0-L	0L	4K 4K		ST	G/B
M* 0L-01H	A	PDP-0L EXTENDED MEMORY CONTROL (12K)	8-15-74	KM0-L	0L	4K 8K		ST	G/B
M* 0L-05A	A	PDP-0L MEMORY PARITY IOT TEST	8-15-74	MP0-L	0L	4K 4K		ST	G/B
M* 0L-06MA	A	VNOBEL	8-15-74	DM0-L	ALL 0L	4K 4K		ST	G/B



IDENTIFICATION

PRODUCT CODES:

PRODUCT NAMES:

POP- BS MAINDEC INDEX BY APPLICATION



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 \*\*\* APPLICATION: PROCESSOR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM	CORE K	TO SYSTEM	MODES	IXXDP	D/S
			DATE		RUNS IN	LOAD HUN	BASED	OF OPER	EXT	CODE
M- 8S-001	A	INSTRUCTION TEST	8-15-74		8S	4K	4K	ST		G/B
M- 8S-003	A	BASIC JMP-JMS TEST	8-15-74		8S	4K	4K	ST		G/B
M- 8S-004	A	RANDOM JMP TEST	8-15-74		8S	4K	4K	ST		G/B
M- 8S-005	B	RANDOM JMP-JMS TEST	8-15-74		8S	4K	4K	ST		G/B
M- 8S-006	A	RANDOM OCA TEST	8-15-74		8S	4K	4K	ST		G/B
M- 8S-007	A	RANDOM ISZ TEST	8-15-74		8S	4K	4K	ST		G/B

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 \*\*\* APPLICATION: PROCESSOR OPTION \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM	CORE K	TO SYSTEM	MODES	IXXDP	D/S
			DATE		RUNS IN	LOAD HUN	BASED	OF OPER	EXT	CODE
M- 8S-086	A	DWB-S DATA BREAK TEST 1	9-15-67	UB08-S	8S	4K	4K	ST		G/B
M- 8S-08C	A	DWB-S DATA BREAK TEST 2	6-15-67	UB0-S	8S	4K	4K	ST		G/B

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 \*\*\* APPLICATION: MEMORY \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD MUN	TO(SYSTEM) BASED	MODES UP OPEN	XXD/FI/O/S TEXT CODE
M- 8S-D15	A	PDP-8S 4K SENSE AMPLIFIER TEST	9-24-74		8S	4K 4K		ST	G/B
M- 8S-D1L	A	PDP-8S MEMORY ADDRESS TEST	8-15-74		8S	4K 4K		ST	G/B
M- 8S-D11	J	PDP-8S MEMORY ADDRESS TEST	8-15-74		8S	4K 4K		ST	G/B
M- 8S-D1S	A	PDP-8S 4K SENSE AMPLIFIER TEST	8-15-74		8S	4K 4K		ST	G/B



IDENTIFICATION

PRODUCT CODE:

PRODUCT NAME:

PDP- X6 MAINDEC INDEX BY APPLICATION



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 \*\*\* APPLICATION: SYS. EXERCISUR \*\*\*  
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DESIGNATION	REV/MCD	PRODUCT NAME	IEFFECTIVE   DATE	OPTION(S) TESTED	IPROC PROGRAMICURE   RUNS IN	K TO(SYSTEM) LOAD RUN	MODES BASED UP	IXXDPI/S OF OPER	TEXT CODE
M= X8-DIG&C	A	DEC/X8 SOFTWARE MODULE INTERFACE SP	1-25-72						G/B
M= X8-DIXYA	A	DEC/X8 MODULE "PLUTTER"	12-28-72	XY8-E /XY12 VP8-L /VP8-I		4K 4K 8F	5Y		G/B
M= X8-DUTCA	A	DEC/X8 MODULE "TIC12LT"	1-25-72	TC12		4K 4K	5Y		G/B
M= X8-QHADA	A	DEC/X8 MODULE "ADMSTT"	3-15-76	MM01/MS/	8E 8M 8F 8A	4K 4K PDP=08	5Y		G/B
M= X8-DHCPA	A	DEC/X8 MODULE "CAMDBE"	7-27-73	CR8-E /CR8-F CM8-E /	8E	4K 4K	5Y		G/B
M= X8-DHICA	A	DEC/X8 MODULE "TC8X8"	6-15-75	ICS=8	8L 8M 8F 8L 8A	4K 4K	5Y		G/B
M= X8-DHKEA	A	DEC/X8 MODULE "EACDP"	1-25-72	KE8-E	8E 8M	4K 4K	5Y		G/B
M= X8-DHARA	A	DEC/X8 MODULE "RR8E0S"	9-07-72	KK8-E +KK8-F KK8S /RK8S	+ 8B 8I 8L 8E 8M	4K 4K	5Y		G/B
M= X8-DHLGA	A	DEC/X8 MODULE "LGM8"	5-01-77	LOP=8	8E 8F 8M 8A	4K 4K PDP=8	5Y		G/B
M= X8-DHRYA	B	DEC/X8 MODULE "FLUPPY"	12-15-76	HY8-E +RX8I	8E 8M 8F 8A	4K 4K	5Y		G/B
M= X8-DHTAA	B	DEC/X8 MODULE "TABECS"	10-15-73	TAB-E D	8E 8M	4K 4K	5Y		G/B

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 \*\*\* APPLICATION: SYS. EXERCISUR \*\*\*  
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DESIGNATION	REV/MCD	PRODUCT NAME	IEFFECTIVE   DATE	OPTION(S) TESTED	IPROC PROGRAMICURE   RUNS IN	K TO(SYSTEM) LOAD RUN	MODES BASED UP	IXXDPI/S OF OPER	TEXT CODE
M= X8-DHTDA	B	DEC/X8 MODULE "TDBEDT"	3-15-76	TDB-E		4K 4K 04	5Y		G/B
M= X8-DHTHA	B	DEC/X8 MODULE "TMBEMT"	11-17-73	TMB-E		4K 4K	5Y		G/B
M= X8-DHVCA	A	DEC/X8 MODULE "VCADBE"	12-15-72	VCR-E /ADR-E VR14 AM8-E	/ 0B 8I 8L 8E 8M	4K 4K	5Y		G/B
M= X8-DHNTA	A	DEC/X8 MODULE "VT8E"	12-04-72	VT8-E		4K 4K	5Y		G/B
M= X8-DICDA	A	DEC/X8 MODULE "CDPB"	5-01-73	COP		4K 4K	5Y		G/B
M= X8-DIOCA	A	DEC/X8 MODULE "DC02"	2-26-72	DC02		4K 4K	5Y		G/B
M= X8-DIOCR	A	DEC/X8 MODULE "DC08A"	12-27-72	DC08	/DLB=1	8I	4K 4K	5Y	G/B
M= X8-DIOFA	B	DEC/X8 MODULE "DFJ21S"	12-12-73	DFJ2		4K 4K	5Y		G/B
M= X8-DIOKA	C	DEC/X8 MODULE "TIMERA"	1-26-75	DK8-E /K8=1	/ VR	4K 4K	5Y		G/B

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 \*\*\* APPLICATION: SYS. EXERCISUR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PRG PROG RUNS IN	PHG LOAD	PHG MUN	PHG BASED	PHG OPEN	PHG TEXT	PHG CODE
				Kx12-A /KWB-L							
M- X8-DIFPA	A	DEC/X8 MODULE "FPP12"	4-21-72	FPP12	08 0I 0L 0E 0M	4K	4K		0Y		G/B
M- X8-DIKAA	A	DEC/X8 MODULE "MR10BA"	1-26-72		08 0I 0L 0E 0M	4K	4K		0Y		G/B
M- X8-DIKAC	B	DEC/X8 MODULE "OPERATE"	4-21-72		08 0I 0L 0E 0F	4K	4K		0Y		G/B
M- X8-DIKAD	B	DEC/X8 MODULE "NOIFUN"	5-18-72		08 0I 0L 0E 0M	4K	4K		0Y		G/B
M- X8-DIKEA	B	DEC/X8 MODULE "EALALL"	9-07-72	KEB-E	0E 0M	4K	4K		0Y		G/B
M- X8-DIKLA	A	DEC/X8 MODULE "MULTTY"	4-03-72	KLB-E /KLB-J	0I 0L 0B 0E 0M	4K	4K		0Y		G/B
M- X8-DIKLB	B	DEC/X8 MODULE "TITLUP"	5-15-75	KLB-E /KLB-J / KLB-M	0E 0M 0F 0I 0L 0A 0 12	4K	4K		0Y 0G		G/B
M- X8-DIKLC	A	DEC/X8 MODULE "MULSLU"	3-15-76	KLB-A /	0E 0M 0F 0A	4K	4K	PDP-8	0Y		G/B

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 \*\*\* APPLICATION: SYS. EXERCISUR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PRG PROG RUNS IN	PHG LOAD	PHG MUN	PHG BASED	PHG OPEN	PHG TEXT	PHG CODE
M- X8-DIKLD	A	DEC/X8 MODULE "MSLULP"	12-15-76	KLB-A	0E 0M	4K	4K	PDP-8	0Y		G/B
M- X8-DILPA	B	DEC/X8 MODULE "PINTER"	4-28-72	LP08 +LE0 LS0-E /LS0-E	0I 0B 0L 0E 0M	4K	4K		0Y		G/B
M- X8-DIPAA	A	DEC/X8 MODULE "TYMSET"	11-02-73	UCB-E /UCB-L / UC12 /DAB0 / UC0-I /PA61	0I 0B 0L 0E 0M	4K	4K		0Y		G/B
M- X8-DIPCA	A	DEC/X8 MODULE "HSMHSP"	1-25-72	PC0-E /PC12 / PC0-L /PC0-I	0B 0I 0L 0E 0M	4K	4K		0Y		G/B
M- X8-DIQAA	C	PROCEDURAL ABSTRACT	11-19-73		08 0I 0L 0E 0M				0Y		G/B
M- X8-DIQAB	C	DEC/X8 USLWS GUIDE + MON/BUILDOR	10-31-73		08 0I 0L 0E 0M	4K	4/8K		0Y		G/B
M- X8-DIQAC	A	DEC/X8 SOFTWARE MODULE INTERFACE SP	1-25-72		08 0E 0I 0L 0M				0Y		G/B
M- X8-DIQAF	J	DEC/X8 SOFTWARE MODULE INDEX	8-01-77		08 0I 0L 0E 0M				0Y		G/B

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 \*\*\* APPLICATION: SYS, EXERCISUR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM CORE K RUNS IN	TO SYSTEM MODES	LOAD RUN BASED	OF OPEN TEXT	ICD/S CODE
M= X8-DIRFA	A	DEC/X8 MODULE "RF08US"	1-25-72	RF08	08 07 08 0E 12	4K	4K	SY	6/8
M= X8-DIRKA	A	DEC/X8 MODULE "RK08S"	8-15-74	NK08	08 01 08 0E 12	4K	4K	SY	6/8
M= X8-DITCA	B	DEC/X8 MODULE "TC01DT"	9-07-72	TC01	08 01 08 0E 12	4K	4K	SY	6/8
M= X8-DITCB	C	DEC/X8 MODULE "TC084T"	9-07-72	TC08	08 01 08 0E 12	4K	4K	SY	6/8
M= X8-DJFPA	A	DEC/X8 MODULE "FPP8-A"	12-15-76	FPP8-A /	0E 0A	4K	4K	PDP-8 SY	6/8
A= X8-DIQAB	A	APT-8 SYSTEM DEC/X8	10-15-75	DEC/X8 /APT-8	ALL08	8K	8K	SY 06	6/8
D= X8-DIQAO	C	DEC/X8 DETAILED CONCEPTS + METHODS	10-31-73		08 01 08 0E 0E			SY	6/8

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 \*\*\* APPLICATION: DIAGNOSTIC PKG \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM CORE K RUNS IN	TO SYSTEM MODES	LOAD RUN BASED	OF OPEN TEXT	ICD/S CODE
M= X8-DJGAA	L	DEC/X8 FILE LINDTAPE	8-01-77	TC12 /TUS5 /	ALL 12	8K	8K	SY	6/8
M= X8-DIQAE	L	DEC/X8 DECTAPE	8-01-77	TC08 /TC01 /TUS5	12 8 01 08 0E	8K	8K	SY	6/8
M= X8-DJRYA	F	DEC/X8 FILE "FLOPPY"	8-01-77	RX0-E +RX01	0E 0M 0F 0A	8K	8K	SY	6/8



IDENTIFICATION

PRODUCT CODE:

PRODUCT NAME:

POP- 05 MAINDEC INDEX BY APPLICATION





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 \*\*\* APPLICATION: DOCUMENT \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PRDC PROGRAMICORE RUNS IN	K TOISYSTEM LOAD RUN BASED	MODES OF OPEN	IXX0PIDS TEXT CODE
M= 08-DHMEA	B	POP=8 DIAGNOSTIC MEDIUM	7-15-75	MXB-E MXB-L	+MX05 / ALL 00 +MX01	BK 0A		G/B
M= 08-DIQIC	E	POP=8 MAINDEC INDEX	8-01-77					G/B
D= 08-ECLMA	A	CLA MAINTENANCE GUIDE	6-15-75	CLB CMS1	/DS310 / CLB /CLASSIC CMS1 CLASS		UT	G/B

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 \*\*\* APPLICATION: MODULE TEST \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PRG RUNS IN	PROGRAM LOAD NUM	CORE BASED	MODES OF OPEN	TEXT CODE
A- 08-QHMB	B 0 223	8KBAA MEMORY EXERCISER PROGRAM	9-15-75	2223-0 G649 MM848 +G650 M219-A,	+ PDP-8E	20K	20K	PDP8 ST	G/B
A- 08-QHLA	G 0 1436	PONEX SUPPLY TEST	4-15-76		KK8E	4K	4K	PDP8 ST	G/B

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 \*\*\* APPLICATION: PROCESSOR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PRG RUNS IN	PROGRAM LOAD NUM	CORE BASED	MODES OF OPEN	TEXT CODE
M- 08-002	B	INSTRUCTION TEST PART 28	1-12-68		08	4K	4K	ST	G/B
M- 08-003	A	BASIC JMP-JMS TEST	4-01-67		08	4K	4K	ST	G/B
M- 08-004	B	RANDOM JMP TEST	1-12-68		08	4K	4K	ST	G/B
M- 08-005	B	RANDOM JMP-JMS TEST	1-12-68		08	4K	4K	ST	G/B
M- 08-007	B	RANDOM ISZ TEST	12-28-67		08	4K	4K	ST	G/B
M- 08-0HK4A	B	BE ADDER TESTS	11-15-75			4K	4K	UG ST	G/B
M- 08-0HKAB	A	RANDOM AND TEST	4-12-73		0E	4K	4K	ST	G/B
M- 08-0HKAF	A 0	PDP-8/E INSTRUCTION TEST 1	7-15-75		ALL 08	4K	4K	UG ST	G/B
M- 08-0HKAG	A	PDP-8/E INSTRUCTION TEST 2	12-15-75			4K	4K	UG ST	G/B
M- 08-DIKAA	A	RANDOM TAD TEST	12-15-76	OBSOLETES: M 0E D08H	ALL 08	4K	4K	PDP-8 ST	G/B
M- 08-DIKIA	A	PDP-8 INSTR TST PNT2A	5-01-77	OB SOLETES: M 0B D0E		4K	4K	PDP-8 ST	G/B
M- 08-DJKKA	C	PDP-8/A CPU TEST	5-01-77	PDP-8/A ACT-8/A/ CPU-XOR		1K	1K	ST	G/B
M- 08-DJKKB	A	PDP-8A CPU TEST WITH CONSOLE PACKAG	7-15-75		BE-8A	4K	4K	PDP8 ST	G/B
M- 08-0KVTA	A	VT78 MOS MEMGRY DIAGNOSTIC	8-01-77	VT78	VT78			ST	G/B
M- 08-0KVTB	A	VT78 CPU DIAGNOSTIC	8-01-77	VT78	VT78			ST	G/B

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 \*\*\* APPLICATION: PROCESSOR OPTION \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAMS IN	CORE K	TDISYSTEM	MODES	IXXDP	IO/S
M= 08-00A	A	INSTRUCTION TEST (EAE) PT.3A	8-06-74	KEB-E	0E	4K	4K	ST		G/B
M= 08-00B	A	INSTRUCTION TEST (EAE) PT.4B	8-06-74	KEB-E	0E	4K	4K	ST		G/B
M= 08-01K	B	KP&I/KR01 POWER FAIL TEST	2-02-71	XP0-I /KR01	0B 01	4K	4K	ST		G/B
M= 08-06C	C	CALCOMP PLOTTER TEST	4-23-69	VP0-I	0B 01 0L	4K	4K			G/B
M= 08-06G	C	A/D CALIBRATION CHECK	8-06-74	AF01A /ADU1	0B 01 0S	4K	4K			G/B
M= 08-06H	A	A/D DIAGNOSTIC AND DEMO	8-06-74	AF00A	0B	4K	4K	ST		G/B
M= 08-06J	D	A008 DIAGNOSTIC	8-06-74	AD08	0B	4K	4K	ST		G/B
M= 08-06K	C	VC01 S/W DISPLAY TEST	12-01-70	VC0-I	01	4K	4K			G/B
M= 08-06M	A	V336 DISPLAY DIAGNOSTIC	8-06-74	J36 /V336	0	4K	4K	ST		G/B
M= 08-06Q	A	LOW LEVEL MULTIPLEXER	8-06-74	AM03	0B	4K	4K	ST		G/B
M= 08-06T	A	AA05/AA07 CALIBRATION CHECK	12-18-60	AA05 /AA07	0B 01 0S	4K	4K	ST		G/B
M= 08-06U	B	A001-A DIAGNOSTIC	9-24-74	AD01	01	4K	4K	ST		G/B
M= 08-06W	B	AA50 I/A CONVERTER	9-24-74	AA50	00	4K	4K	ST		G/B
M= 08-06 6U	B	A001-A DIAGNOSTIC	8-06-74	AD01	01	4K	4K	ST		G/B
M= 08-068	A	ONLINE I0MS360 TO DX08/9 EXER.	5-21-74	J36 BUFFERE DISPLAY		4K	4K	ST		G/B
M= 08-06L	A	D068 TEST	8-12-74	0B48	0B	4K	4K	ST		G/B
M= 08-06I	B	D008A TEST	8-06-74	0B48	0B	4K	4K	ST		G/B
M= 08-06M	B	VA36 CHARACTER GENERATOR TEST	8-06-74	VA36	0B	4K	4K	ST		G/B
M= 08-06S	C	DM01 EXERCISER	8-06-74	DM01	0B	4K	4K	ST		G/B

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 \*\*\* APPLICATION: PROCESSOR OPTION \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAMS IN	CORE K	TDISYSTEM	MODES	IXXDP	IO/S
M= 08-08T	A	S14360/I0MS360 CHANNEL SIMULATOR	8-06-74	UX08 /DX36 / 0	UX56	4K	4K	ST DT		G/B
M= 08-08U	B	DX06-S360 DIAGNOSTIC EXERCISER	8-06-74	UX08 /DX36 / 0	UX56	4K	4K	ST DT		G/B
M= 08-08X	A	XUR BUFFER OPTION DIAGNOSTIC	8-06-74	CPU-XUR BUFFER	0B	4K	4K	ST		G/B
M= 08-09M	A	IOT AND DATA TEST 6501	8-06-74	UP01A	0B	4K	4K	ST		G/B
M= 08-09N	A	IOT AND DATA TEST 6501	8-06-74	UP01A	0B	4K	4K	ST		G/B
M= 08-09P	A	IOT AND DATA TEST 6601	8-06-74	UP01A	0B	4K	4K	ST		G/B
M= 08-09Q	A	IOT AND DATA TEST 6701	8-06-74	UP01A	0B	4K	4K	ST		G/B
M= 08-09ORA	A	0RB-EA DIAGNOSTIC TPL PDP-8	8-06-74	0RB-EA +DAB-E	0D 01 0L	4K	4K	ST		G/B
M= 08-0MADA	A	A08E, AM8E A/D CONVERTER + MUX	8-06-74	ADME /AM8E	0E	4K	4K	ST		G/B
M= 08-0MFA	A	COP/GLC-08E DIAGNOSTIC	8-06-74	COP/GLC	0B	4K	4K	ST		G/B
M= 08-0MDPA	D	DPB-EA/EB SYNC. MODEM INTERFACE DIA	5-01-77	DPB-EA /DPB-EB / 0/A DPB-E 0/M	0/E	4K	4K	ST		G/B
M= 08-0MDRA	B	0MB-EA 12 CHANNEL BUFFERED DIGITAL	11-15-75	0RB-EA	0E	4K	4K	UG ST		G/B
M= 08-0MKEA	B	EAE EXTENDED MEMORY EXERCISER	8-15-76	KEB-A	ALL 0B	4K	4K	PDP-8 BU		G/B
M= 08-0MKEB	A	KEB-E (EAE) INSTRUCTION TEST 1	8-15-76	KEB-A OBSOLETE:IM 0E	ALL 0B 00L	4K	4K	PDP-8 ST		G/B
M= 08-0MKEC	A	KEB-E (EAE) INSTRUCTION TEST 2	8-15-76	KEB-E OBSOLETE:IM 0E	ALL 0B 00M	4K	4K	PDP-8 ST		G/B
M= 08-0MKIC	C	DOUBLE BUF ASYNC INTERFACE DIAG	3-26-73	KL8-F	0E 0M 0F	4K	4K			G/B
M= 08-0MKLA	A	KL8M MODEM CONTROL DIAGNOSTIC	6-26-72	KL8-M	0E 0M 0F	4K	4K			G/B

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 \*\*\* APPLICATION: PROCESSOR OPTION \*\*\*  
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DESIGNATION	REV/MOD	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE X LOAD RUN	IO BASED	SYSTEM MODES	OPER TEXT	IXDPID/S CODE
M- 08-DHKLB	B 1	KL8M KL8E/F DC08M ONLINE TEST	10-15-75	KL8-E /DC08M / KL8-M /KL8-F	BE 0M 0F 0A	4K 4K		ST		G/B
M- 08-DHKLC	D	KL8-F DBLE BUFFERED ASYNC INTERFACE	5-01-77	KL8-F	ALL 08	4K 4K		ST		G/B
M- 08-DHKLD	A	BE TTY & KL8 ASYNC DATA CONT	4-06-72	KL8	*ASR-53	0E 0M 0F		ST		G/B
M- 08-DHKEA	B	POWER FAIL/AUTO RESTART TEST	4-06-73	KP8-L	0E	4K 4K		ST		G/B
M- 08-DHVEA	A	VC8E DISPLAY DIAGNOSTIC	3-01-73	VC8-E	0E 0M 0F	4K 4K		ST		G/B
M- 08-DHVTB	B	VT8-E VIDED DISPLAY TEST	8-06-74	VT8-E	0E	4K 4K		ST		G/B
M- 08-DHVTB	A	VT8-E VIDED DISPLAY TEST 2	8-06-74	VT8-E	0E	4K 4K		ST		G/B
M- 08-DIADF	A	ADUBI DIAGNOSTIC	8-06-74	ADVB1		4K 4K		ST		G/B
M- 08-DIAFB	A	AFCB DIAGNOSTIC	8-06-74	AFC-0	0I 0L	4K 4K		ST		G/B
M- 08-DIDBA	A	DB8-E	5-01-77	DB8-E	ALL 08			ST		G/B
M- 08-DIUCA	B	UOCB SYSTEM FUNCTION EXERCISER	5-06-74	UOC-0	ALL 08	4K 4K		ST		G/B
M- 08-DIVTB	A	D VIZG MUST COMPUTE PROGRAM	7-21-74	KL8-JA	ALL 08	4K 0K		DT		G/B
M- 08-DJAD0	C	0 A/D CONVERTER MULTIPLEXER DIAGNOSTIC	5-15-76	AD002	ALL 08	4K 4K	PDP-8	ST		G/B
M- 08-DJCLA	A	CL8 OPTION TEST 1 AND 2	8-15-75	UKC8-AA+KM8-A	0A	4K 4K		ST		G/B
M- 08-DJFPA	A	FPP8-A DIAGNOSTIC	8-15-76	FPP /	0A		PDP-8	ST		G/B
M- 08-DJFPB	B	FPP8-A INSTR, TEST AND DATA EX.	5-01-77	FPP-0A /	0A 0E	0K 0K	PDP-8	ST		G/B
M- 08-DJKLA	C	0 KL8-A MULTIPLE SERIAL LINE UNIT DIA	9-15-76	KL8-A/A/APT-0/A	0A	4K 4K	PDP-8	ST		G/B
M- 08-DJNRB	A	MN8-SA ROM MAINTENANCE DIAG.	8-01-77	MN8-SA	0A		PDP-8	ST		G/B
M- 08-DJNRC	A	MN8-SA ROM MAINTENANCE DIAG.	8-01-77	MN8-SA	0A					G/B

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 \*\*\* APPLICATION: MEMORY \*\*\*  
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DESIGNATION	REV/MOD	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE X LOAD RUN	IO BASED	SYSTEM MODES	OPER TEXT	IXDPID/S CODE
M- 08-D1A	C	MEMORY POWER ON/OFF TEST	9-16-60		08	4K 4K		ST		G/B
M- 08-D1E	C	EXTENDED MEMORY CHECKERBOARD	8-12-74	MM8 /MM8-I	08 0I	0K 0K		ST		G/B
M- 08-D1H	A	EXTENDED MEMORY ADDRESS TEST	8-12-74	MM8 /MM8-I	08 0I	0K 0K		ST		G/B
M- 08-D1L	2	BASIC MEMORY CHECKERBOARD (HIGH)	8-12-74		0	4K 4K		ST		G/B
M- 08-D1M	A	MEMORY ADDRESS TEST	2-16-71		08	4K 4K		ST		G/B
M- 08-D1A	2	8/I, 8 BASIC PARITY CHECKERBOARD	8-12-74	MP8 /MP8-I	08 0I	4K 4K		ST		G/B
M- 08-D1B	A	EXTENDED MEMORY PARITY TEST	8-12-74	MP8 /MP8-I	08 0I	0K 0K		ST		G/B
M- 08-DDRMA	A	0 0M812-I EXT MEM DATA & CHECKBO TEST	7-21-74	0M812-I	0I 12	4K 32K		ST		G/B
M- 08-DGMDA	A	EXTENDED MEMORY CONTROL	3-29-73	MM8-I /MM8-0 ME8-0 /	08 0I 0S	0K 0K		ST		G/B
M- 08-DHKAC	A	0 MM8E MEMORY CHECKERBOARD	7-15-75		0E 0M 0F	4K 4K		0G ST		G/B
M- 08-DHKAD	A	0 MEMORY ADDRESS TEST	7-15-75		ALL 08	4K 4K		0G ST		G/B
M- 08-DHKMA	C	PDP-8E EXTENDED MEMORY DATA & CHECK	2-15-76	KM8-E /KM8-A / PDP-0A /PDP-0E / APT-0A /CL8	0E 0M 0F 0A	4K 0K		0G ST		G/B
M- 08-DHKMC	B	0 PDP-8E EXTENDED MEMORY ADDRESS TEST	5-15-76	KM8-E /IM8-A / APT-0A	0E 0M 0F 0A 0A	4K 0K	PDP-8	0G ST		G/B
M- 08-DHMDA	B	PDP-8E MEM EXT. AND T.S. CONTROL TE	12-15-76	KM8-E	0E	4K 4K		ST		G/B
M- 08-DHMR1	A	ROM CONTENTS	5-16-72	MR8-E	0E	4K 4K		ST		G/B
M- 08-DHMR2	B	MR8-EA READ ONLY MEMORY TEST	8-01-77	MR8-E	0E	4K 4K		ST		G/B

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 \*\*\* APPLICATION: MEMORY \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD NUM	TO SYSTEM BASED	MODES OF OPEN	IXXDPIO/S TEXT CODE
M- 08-DHMRP	A	MR0-F0 2K PROM INTERNAL TEST	7-21-74	MR0-F0	0E	2K 2K		ST	6/B
M- 08-DHFB0	A	PROM BLASTER PROGRAM	12-15-75	MR073A		4K 4K		ST	6/B
M- 08-DJHRA	A	MR0-A ROM COMPARE TEST	10-15-75	MR0-A	0A	1K 1K		ST	6/B
M- 08-DJMSA	A	1-0K MS0-A MOS MEMORY TEST	10-15-74	MS0-A /ACT-B/E/ ACT-0/A/CPU-XOR	0A	1K 1K		ST	6/B
A- 08-DHMCA	A	2223 0K11C MEMORY EXERCISER PROGRAM	6-01-75	MM11-B,+M221-AR+ MM11-C,+M222-AB+ MM11-D,+G651,2	ALL 03	16K 16K	PDP-8	US ST	6/B
A- 08-DHMGA	C	2223 0K8EJ MEMORY EXERCISER PROGRAM	6-15-75	MM8E +MM8EJ		16K 16K	PDP-8	US ST	6/B
A- 08-DHMBA	B	2223 MS0AA MEMORY EXERCISER PROGRAM	6-15-75	MS0AA +1K,2K,3+ 4K		16K 16K	PDP-8	US ST	6/B
A- 08-DHSEC	D	2223 STACK EXERCISER FOR M217 AND M	11-15-75	M217 /M224 M217C /M217U	PDP-8 PDP-8 PDP-8	24K 24K	PDP-8	ST	6/B
A- 08-DHSED	A	2223 STACK EXERCISER FOR M221 AND M	11-15-75	M221 /M222		24K 24K	PDP-8	ST	6/B
A- 08-DHSEE	A	2223 STACK EXERCISER FOR M219 STACK	11-15-75	M219		24K 24K	PDP-8	ST	6/B

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 \*\*\* APPLICATION: CLOCKS \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD NUM	TO SYSTEM BASED	MODES OF OPEN	IXXDPIO/S TEXT CODE
M- 08-D0VB	B	KW068 CLOCK TEST	8-12-74	KW068	00	4K 4K		ST	6/B
M- 08-D0DKA	A	0K8E CLOCK DIAGNOSTIC	11-15-75	0K0-EA /0K0-EC / 0K0-EP /0K0-ES	0E 0M 0F 0A	4K 4K		ST	6/B

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 \*\*\* APPLICATION: PAPER TAPE \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	INEFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K TO LOAD RUN	SYSTEM BASED	MODES OF OPER	IKXDPID/S TEXT CODE
M- 08-02U	A	PA60C DIAG	8-12-74	PA60-C	ALL 08	4K 4K		ST	G/B
M- 08-0HPCA	A	HIGH SPEED READER/PUNCH TST	5-01-77	PCB-E	8E 9M	4K 4K		ST	G/B

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 \*\*\* APPLICATION: CARD \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	INEFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K TO LOAD RUN	SYSTEM BASED	MODES OF OPER	IKXDPID/S TEXT CODE
M- 08-02N	B	CR01C CARD READER TEST	8-06-74	CR01C	08	4K 4K		ST	G/B
M- 08-02O	A	CR03 CARD READER TEST	8-12-74	CR03	08	4K 4K		ST	G/B
M- 08-0HCMA	A	80 CCL OPTICAL CARD READER TEST	8-12-74	CR0-F	8E	4K 4K		ST	G/B
M- 08-0HCRA	A	CR8E/CR8F CARD READER TEST	8-12-74	CR8-E /CR8-F	8E	4K 4K		ST	G/B

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 \*\*\* APPLICATION: TERMINALS \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE   DATE	OPTION(S) TESTED	PMDC PROGRAM/CORE K TO SYSTEM   RUNS IN	MODES   LOAD RUN   BASED  UF OPEN  EXT  CODE	IXXPID/S
M- 08-020	A	LT08 TELEPRINTER TEST	8-12-74	LT08	3	4K 4K	ST G/B
M- 08-02A	A	DC02 FAMILY-OF-EIGHT TELETYPE TEST	8-12-74	PT08 DC02 ASH35	+ LT08 + ASR35 / 12	4K 4K	ST G/B
M- 08-02P	E	FAMILY OF 8 ASR33/35 TTY TEST 1	2-21-69	ASH-53	/ASH35	8S 08 8I	4K 4K ST G/B
M- 08-02G	D	FAMILY OF 8 ASR33/35 TTY TEST 2	6-04-68	ASH-33	/ASR-35	09 8I 08	4K 4K ST G/B
M- 08-08P	A	PT08 DATAPHONE	8-19-68	PT08-B	/PT08-C	08	4K 4K ST G/B
M- 08-08H	A	DC02 TELETYPE FLAW TEST	8-12-74	DC02		8I 0L 12	4K 4K ST G/B
M- 08-08LAA	A	DECWRITER CONTROL EXERCISER	2-16-73	L430		4K 4K	ST G/B
M- 08-08LQA	B	LOOP PRINTER DIAGNOSTIC	8-01-77	LQP8		ALL 08	4K 4K PDP-8 ST G/B
M- 08-08VTC	D	VT50-VT52 VIDEO TERMINAL ACCEPTANCE	8-15-76	VT50-VT VT50J	VT50B /VT50H	/ ALL 08	4K 4K ST G/B
M- 08-08VTD	A	VT61 VIDEO TERMINAL ACCEPTANCE TEST	8-15-76	VT61		ALL 08	4K 4K PDP-8 ST G/B
M- 08-08KLB	B	KL8-JA/KR/KC/KU LOOP BACK TEST	8-15-74	KL8-JA	/KR/KR/K	ALL 08	4K 4K ST G/B
M- 08-08LAB	D	L436 TERMINAL DIAGNOSTIC	10-15-75	L436 L437	/L435 DC02	/ ALL 08	4K 4K PDP8 ST G/B
M- 08-08LAC	B	L4180 PRINTER DIAGNOSTIC	7-15-76	L4180		ALL 08	4K 4K PDP-8 ST BIN G/B
M- 08-08LPA	C	LE8/LP06 LINE PRINTER TEST	8-15-75	LE8	/LP08	08 0I 0L 0E	4K 4K ST G/B
M- 08-08LPE	C	LP06/LP05 LINE PRINTER TEST	8-01-77	LE8 LP05	/LP08	+ ALL 08	4K 4K PDP8 ST G/B
M- 08-08LVA	A	LV12/LVB PRINTER/PLOTTER TEST	8-12-74	LV12	/LV8-E	ALL 08	4K 4K ST G/B

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 \*\*\* APPLICATION: TERMINALS \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE   DATE	OPTION(S) TESTED	PMDC PROGRAM/CORE K TO SYSTEM   RUNS IN	MODES   LOAD RUN   BASED  UF OPEN  EXT  CODE	IXXPID/S
M- 08-08PAA	A	FAMILY OF 8 TYPESLY CONFIG TESTS	8-12-74	PAB0	/PAB3	ALL 08	ST G/B
M- 08-08RTA	A	RT01/02 TERMINAL DIAG	8-12-74	RT01 RT02 PT08	/DC02 /KLB	/ ALL 08	4K 4K ST G/B
M- 08-08VTC	A	VT55 VIDEO TERMINAL ACCEPTANCE TEST	8-15-75	VT55		ALL 08	4K 4K PDP-8 ST BIN G/B

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 \*\*\* APPLICATION: MAGNETIC TAPE \*\*\*  
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DESIGNATION	REV/MCD	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD	SYSTEM BASED	MODES OF OPEN	TEXT CODE	IXXDP10/S
M- 08-03E	B	TC01 EXT MEMORY EXER	1-05-68	TC01 /TC08 TU55 /TU56	/ ALL 08	4K 0K		ST		G/B
M- 08-03F	C	INCREMENTAL TAPE UELAY TEST	8-12-74	TR02 +TU20	8I 8L 8E	4K 4K		ST		G/B
M- 08-03R	A	TC01 RANDOM EXERCISER	1-09-67	TC01 /TC08 TU56 /TU55	/ ALL 08	4K 4K		ST		G/B
M- 08-04C	B	INCREMENTAL TAPE COMPATIBILITY (PUP	8-12-74	TR02 +TU20	8I 8L	4K 4K		ST		G/B
M- 08-04D	A	INCREMENTAL TAPE DATA RELIABILITY	8-12-74	TR02 +TU20	8I 8E 8L	4K 4K		ST		G/B
M- 08-04E	B	P&C INCREMENTAL TAPE INSTR TEST	8-12-74	TR02 +TU20	8I 8L 8E	4K 4K		ST		G/B
M- 08-04F	B	P&C INCREMENTAL TAPE RANDOM EXERCIS	8-12-74	TR02 +TU20	8I 8L 8E	4K 4K		ST		G/B
M- 08-09A	D	DATA RELIABILITY TEST (7 TRACK) (TC	9-14-71	TC58 /TC58 TU20 /	ALL 08	4K 4A		ST		G/B
M- 08-09E	C	INST TEST PART 2 (TC58)	12-03-68	TC58 +TU10 TU20 /	ALL 08	4K 4K		ST		G/B
M- 08-09F	C	DATA RELIABILITY TEST (9 TRACK) (TC	12-25-69	TC58 +TU10 TU20 /	ALL 08	4K 4A		ST		G/B
M- 08-09G	A	TC58 DATA RELIABILITY (9 TRACK) (TU	11-18-68	TC58 +TU30		4K 4K		ST		G/B
M- 08-0HTAA	C	CASSETTE DIAGNOSTIC	8-12-74	TAB-E +TU60	8E	4K 4K		ST		G/B
M- 08-0HTAB	C	CASSETTE DATA RELIABILITY TEST	5-01-77	TAB-E TU60	8E	4K 4K		ST		G/B
M- 08-0HTDA	B	T08E DECTAPE DIAGNOSTIC	5-01-77	T08-E +TU55 TU56 /	8E	4K 4K		ST		G/B
M- 08-0HTMA	B	TMBE CONTROL TEST PART 1	8-01-77	TMB-E +TU10	8E	4K 4K		ST		G/B
M- 08-0HTMB	B	TMBE CONTROL TEST PART 2	8-01-77	TMB-E +TU10	8E	4K 4A		ST		G/B

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 \*\*\* APPLICATION: MAGNETIC TAPE \*\*\*  
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DESIGNATION	REV/MCD	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K LOAD	SYSTEM BASED	MODES OF OPEN	TEXT CODE	IXXDP10/S
M- 08-0HTMD	B	TMBE DATA RELIABILITY (9 TRACK)	8-01-77	TMB-E +TU10	8E	4K 4K		ST		G/B
M- 08-0HTME	B	TMBE DATA RELIABILITY (7 TRACK)	8-01-77	TMB-E +TU10	8E	4K 4K		ST		G/B
M- 08-0HTMF	B	TMBE RANDOM EXERCISER	8-01-77	TMB-E +TU10	8E	4K 4K		ST		G/B
M- 08-0HTMK	A	TMBE DRIVE FUNCTION TIMER	7-16-75	TMB-E +TU10	8E	4K 4K		ST		G/B
M- 08-0HTSA	B	TMB-E/T503 CONTROL TEST PART 1	8-01-77	TMB-E +TS03	ALL 08	4K 4K	PDP-08	ST	BIN	G/B
M- 08-0HTSB	B	TMB-E/T503 CONTROL TEST PART 2	8-01-77	TMB-E /TS03	ALL 08	4K 4K	PUP-08	ST		G/B
M- 08-0HTSC	B	TMB-E/T503 STRK DATA RELIABILITY	8-01-77	TMB-E +TS03	ALL 08	4K 4K	PUP-08	ST	BIN	G/B
M- 08-0HTSD	B	TMB-E/T503 MULTIDIMIVE DATA EXERCISE	8-01-77	TMB-E +TS03	ALL 08	4K 4K	PUP-08	ST	BIN	G/B
M- 08-0HTSE	A	TMB-E/T503 DRIVE FUNCTION TIMER	7-15-75	TMB-E +TS03	ALL 08	4K 4K	PDP-08	ST	BIN	G/B
M- 08-0HTSF	A	TMB-E/T503 UTILITY DRIVER	9-21-75	TMB-E +TS03	ALL 08	4K 4K	PDP-08	ST	BIN	G/B
M- 08-0IYCA	A	TC01 BASIC EXERCISER	5-31-72	TC01 /TU56 TC08 /TU55	/ ALL 08	4K 4K		ST		G/B
M- 08-0ITCB	A	DRIVE FUNCTION TEST (TC58)	4-05-73	TC58 +TU10 TU20 /	ALL 08	4K 4K		ST		G/B
M- 08-0ITCC	A	TC58 RANDOM EXERCISER	3-22-73	TC58 +TU10 TU20 /	ALL 08	4K 4K		ST		G/B
M- 08-0ITCD	A	INST TEST PART 1(TC58)	4-26-73	TC58 +TU20 TU10 /		4K 4K		ST		G/B



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 \*\*\* APPLICATION: DISK \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	[EFFECTIVE] [ DATE ]	OPTION(S) TESTED	[PROC PROGRAM] [ RUNS IN ]	[CORE K TO] [ LOAD RUN ]	[SYSTEM] MODES [BASED IUF OPER]	IXXDPID/S TEXT ICODE
M= 08-05D	B	MULTIUSER DISK EXBA	8-12-74	DF32	08 01	4K 4K	ST	G/B
M= 08-05F	A	RF06 MULTI DISK TEST	3-20-68	RF08	ALL 08	4K 4K	ST	G/B
M= 08-05H	C	RKB DISK DATA RELIABILITY	11-02-70	RKB8	ALL 08	4K 4K	ST	G/B
M= 08-05K	B	RKB DSK FURMATTER	11-18-70	RKB8		4K 4K	ST	G/B
M= 08-0HRKA	E	0 RKB0E/0L DISKLESS CONTR TST	5-01-77	RKB0E RKB0SF RKB0SJ	+ RKB0SJ + RKB0SF + RKB0SF	+ ALL 08	4K 4K PDP-8	ST G/B
M= 08-0HRKE	G	0 RKB0E DRIVE CONTROL TEST	5-15-76	RKB0E RKB0SF RKB0SJ	+ RKB0SJ + RKB0SF + RKB0SF	+ ALL 08	4K 4K PDP-8	ST G/B
M= 08-0HRKC	H	0 RKB0E/0L DATA RELIABILITY	5-01-77	RKB0E RKB0SF RKB0SJ	+ RKB0SJ + RKB0SF + RKB0SF	+ ALL 08	4K 4K PDP-8	ST G/B
M= 08-0HRKD	D	0 RKB0E/0L DISK FORMATTER	5-15-76	RKB0E RKB0SF RKB0SJ	+ RKB0SJ + RKB0SF + RKB0SF	+ ALL 08	4K 4K PDP-8	ST G/B
M= 08-0IDFA	C	DISKLESS LOGIC TEST	8-06-74	DF32D	0E 0F 0H 0I 0L	4K 4K	ST	G/B
M= 08-0IDFB	A	DF32 DISKLESS LOGIC TEST	8-06-74	DF32	0B 0J 0L 0E	4K 4K	ST	G/B
M= 08-0IDFC	A	INTERFACE ADDR DISK DATA TEST	8-12-74	DF32 /DF32D	0B 0S 0I 0L 0E	4K 4K	ST	G/B
M= 08-0IRFA	A	RF06 DISK DATA TEST	3-22-73	RF08	ALL 08	4K 4K	ST	G/B
M= 08-0IRKA	A	RKB DISK AND CONTROL INSTR. EXERCISE	8-01-77	MRB-BA	ALL 08		PDP-8	ST G/B

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 \*\*\* APPLICATION: DISK \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	[EFFECTIVE] [ DATE ]	OPTION(S) TESTED	[PROC PROGRAM] [ RUNS IN ]	[CORE K TO] [ LOAD RUN ]	[SYSTEM] MODES [BASED IUF OPER]	IXXDPID/S TEXT ICODE
M= 08-0IRXA	D	0 RKB/RXB1 DIAGNOSTIC PROGRAM	8-01-77	RKB-E /RX01	ALL 08	4K 8K	PDP-8	ST G/B
M= 08-0IRXB	E	0 RKB/RXB1 DATA RELIABILITY EXERCISER	8-01-77	RKB-E +RX01	ALL 08	4K 8K	PDP-8	ST G/B

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 \*\*\* APPLICATION: DRUM \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	IEFFECTIVE I DATE I	OPTION(S) TESTED	IPROC PROGRAMICORE I RUNS IN I	K TOISYSTEMI ILOAD RUN I	MODES IUF OPER I	IXXDPID/S IEXT ICODE
M= 08-05A	A	MAGNETIC RM08A DRUM TEST	8-12-74	RM08	B	4K 4K	5T	G/B

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 \*\*\* APPLICATION: COMM. EQUIPMENT \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	IEFFECTIVE I DATE I	OPTION(S) TESTED	IPROC PROGRAMICORE I RUNS IN I	K TOISYSTEMI ILOAD RUN I	MODES IUF OPER I	IXXDPID/S IEXT ICODE
M= 08-04KGA	B	K68-EA DIAGNOSTIC	9-15-75	K68-EA	BE 0A	4K 4K PDP-8	5T	G/B

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 \*\*\* APPLICATION: LAB. EQUIPMENT \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K TO LOAD RUN	SYSTEM BASED	MODES OF OPER	TEXT CODE	
M- 08-DHDRH	A	DNB-ED EXERCISER	9-15-75	UR8-ED	ALL 08	4K	4K	PDP-8	BT	6/8

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 \*\*\* APPLICATION: INDUST EQUIPMENT \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CORE K TO LOAD RUN	SYSTEM BASED	MODES OF OPER	TEXT CODE
M- 08-DHICA	A	ICS8 FIELD TEST	9-15-75	ICS8	BE BM BF BA	8K	8K	BT	6/8
A- 08-DHICA	A	ICS8 SYSTEM TEST	12-15-75	ICS8	ALL 08	8K	8K	BT ST	6/8
A- 08-DHICB	A	ICS8 FILE BOX TEST	3-15-76	ICS8	ALL 08	8K	8K	BT	6/8

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 \*\*\* APPLICATION: UTILITY \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFEKTIVE DATE	OPTION(S) TESTED	PRDC PROGRAMICURE RUNS IN	K TO(SYSTEM) LOAD RUN	MODES BASED	UF OPER	TEXT	IXXDPID/S CODE
M= 08-DIPRA	A	PR801 PAPER TAPE READER TOGGLE-IN FD	8-01-77	KL8J	ALL 08		PDP-B	ST		6/8
M= 08-LBA	A	BINARY LOADER	5-10-67		ALL 08	4K 4K		ST		6/8
D= 08-EUF	B	TCQ1 OCTAPE FORMATTER	4-10-70	TC01 TUS6	/TC08 / /TUS5	ALL 08	4K 4K	ST		6/8
D= 08-LBA	B	BINARY LOADER	8-06-74		ALL 08	4K 4K		ST		6/8

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 \*\*\* APPLICATION: SYS. EXERCISOR \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFEKTIVE DATE	OPTION(S) TESTED	PRDC PROGRAMICURE RUNS IN	K TO(SYSTEM) LOAD RUN	MODES BASED	UF OPER	TEXT	IXXDPID/S CODE
M= 08-07C	A	TYPSET + SYSTEM EXERCISER	8-06-74	TC0-E /DF32 TC01 /RF08 TC08 /LP08	/ ALL 08 / /	4K 4K		SY ST		6/8
M= 08-09K	A	FAMILY OF 8 MULTI BREAK DEV EX	8-06-74	UM01 /RR05 TC01 /TC08 DF32 /RF08	/ 08 / 01 0L	4K 4K				6/8
M= 08-0JCLB	A	CLS PRESYSTEM TEST	12-15-75	CL0 /DS310 LMS1	/			ST		6/8

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 \*\*\* APPLICATION: DIAGNOSTIC PKG \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CURE K TO SYSTEM	MODES	TEXT CODE
M- 08-0H05B	N	CDS 300 DIAGNOSTIC MEDIUM	8-01-77	KK0-E KK0-F	/ ALL 08 N	0K 0K	07 08	G/B
M- 08-0JRXA	L	CL/8 FLOPPY MEDIA #1	8-01-77	RX01	ALL 08	0K 0K	PDP-8	G/B
M- 08-0JRXB	D	PDP-8A FLOPPY MEDIA	8-01-77	KXB-E		0K 0K	PDP-8	G/B
M- 08-0JRXC	G	RX01 OPTIUN MEDIA #1	8-01-77	KXB-E		0K 0K	PDP-8	G/B
M- 08-0JRXD	D	RX01 OPTIUN MEDIA #2	8-01-77	KXB-E		0K 0K	PDP-8	G/B
M- 08-0JRXE	C	CL/8 FLOPPY MEDIA #2	8-01-77			0K 0K	PDP-8	G/B
M- 08-0JRXF	B	RX01 OPTIUN MEDIA #3	8-01-77			0K 0K	PDP-8	G/B
M- 08-0JRXG	A	RX01 OPTIUN MEDIA #4	8-01-77					G/B
M- 08-0KRYA	A	VT78 FLOPPY MEDIA	8-01-77				VT0	G/B

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 \*\*\* APPLICATION: OTHER \*\*\*  
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DESIGNATION	REV/MCO	PRODUCT NAME	EFFECTIVE DATE	OPTION(S) TESTED	PROC PROGRAM RUNS IN	CURE K TO SYSTEM	MODES	TEXT CODE
M- 08-02G	I	BIN COUNT PAT TEST TAPE	8-06-74	UC02	08			G/B
M- 08-04J	B	WIRE STORAGE INTERFACE DIAG	8-06-74	UC04-C	08	0K 0K	ST	G/B
M- 08-0HLSA	C	L88 LINEPRINTER TEST	12-15-75	L88	08 01 0L 0E 0M 0A PDP-12	0K 0K	ST	G/B
M- 08-0ILPD	A	LP00/F VERTICAL FORMAT DIAG	7-30-72	LP00	08 12	0K 0K	ST	G/B
M- 08-0ILTC	A	PHOTOCOMP INTERFACE DIAG	1-22-75	LPC-0	0E 01 0L	0K 0K	ST	G/B

